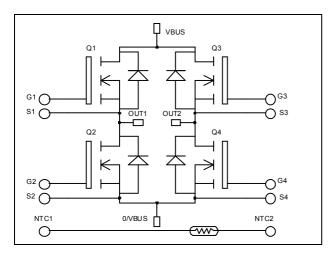


# Full - Bridge MOSFET Power Module

$$\begin{split} V_{DSS} &= 500 V \\ R_{DSon} &= 65 m \Omega \text{ typ @ Tj} = 25^{\circ} C \\ I_D &= 51 A \text{ @ Tc} = 25^{\circ} C \end{split}$$



O/VBUS

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### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

#### **Features**

- Power MOS 7<sup>®</sup> FREDFETs
  - Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Fast intrinsic reverse diode
  - Avalanche energy rated
  - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
  - Symmetrical design
  - Lead frames for power connections
- Internal thermistor for temperature monitoring
- High level of integration

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

#### **Absolute maximum ratings**

**9** G3

**VBUS** 

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Breakdown Voltage		500	V
Ţ	Continuous Drain Current	$T_c = 25^{\circ}C$	51	
$I_{D}$	Continuous Drain Current	$T_c = 80$ °C	38	A
$I_{DM}$	Pulsed Drain current	ulsed Drain current		
$V_{GS}$	Gate - Source Voltage		±30	V
R <sub>DSon</sub>	Drain - Source ON Resistance		78	mΩ
$P_{D}$	Maximum Power Dissipation $T_c = 25^{\circ}C$		390	W
$I_{AR}$	Avalanche current (repetitive and non repetitive)		51	A
E <sub>AR</sub>	Repetitive Avalanche Energy		50	m I
$E_{AS}$	Single Pulse Avalanche Energy		3000	mJ

OUT2

OUT1

NTC2 #

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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## All ratings @ $T_j = 25$ °C unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 500V$	$T_j = 25^{\circ}C$			100	μΑ
		$V_{GS} = 0V, V_{DS} = 400V$	$T_{j} = 125^{\circ}C$			500	
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 25.5A$			65	78	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.5 \text{mA}$		3		5	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$				±100	nA

**Dynamic Characteristics** 

•	Characteristic	Test Conditions	Min	Тур	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$		7000		
$C_{oss}$	Output Capacitance	$V_{DS} = 25V$		1400		pF
$C_{rss}$	Reverse Transfer Capacitance	f=1MHz		90		
$Q_{\mathrm{g}}$	Total gate Charge	$V_{GS} = 10V$		140		
$Q_{\mathrm{gs}}$	Gate – Source Charge	$V_{\text{Bus}} = 250V$		40		nC
$Q_{gd}$	Gate – Drain Charge	$I_D = 51A$		70		
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C $V_{GS} = 15V$ $V_{Bus} = 333V$ $I_D = 51A$ $R_G = 3\Omega$		21		ns
$T_{\rm r}$	Rise Time			38		
$T_{d(off)}$	Turn-off Delay Time			75		
$T_{\mathrm{f}}$	Fall Time			93		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C $V_{GS} = 15V$ , $V_{Bus} = 333V$ $I_D = 51A$ , $R_G = 3\Omega$		1035		1
$E_{\text{off}}$	Turn-off Switching Energy			845		μJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V$ , $V_{Bus} = 333V$ $I_D = 51A$ , $R_G = 3\Omega$		1556		
E <sub>off</sub>	Turn-off Switching Energy			1013		μJ

### Source - Drain diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_S$	Continuous Source current		$Tc = 25^{\circ}C$			51	Α
	(Body diode)		$Tc = 80^{\circ}C$			38	Λ
$V_{\mathrm{SD}}$	Diode Forward Voltage	$V_{GS} = 0V, I_S = -51A$	1			1.3	V
dv/dt	Peak Diode Recovery					15	V/ns
t <sub>rr</sub>	Reverse Recovery Time		$T_j = 25^{\circ}C$			270	ns
ι <sub>rr</sub>	Reverse Recovery Time	$I_S = -51A$ $V_R = 333V$	$T_j = 125$ °C			540	113
$Q_{rr}$	Reverse Recovery Charge	$di_S/dt = 100A/\mu s$	$T_j = 25^{\circ}C$		2.6		μC
Vrr	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		9.6	·	μС

• dv/dt numbers reflect the limitations of the circuit rather than the device itself.

 $I_S \le$  - 51A  $di/dt \le 700 A/\mu s$   $V_R \le V_{DSS}$   $T_j \le 150 ^{\circ} C$ 

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### Thermal and package characteristics

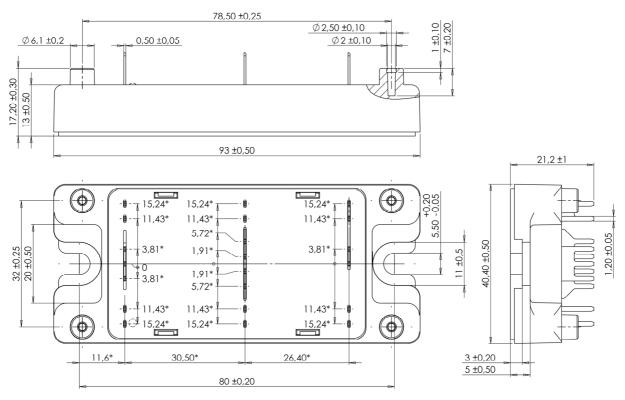
Symbol	Characteristic		Min	Typ	Max	Unit	
$R_{thJC}$	Junction to Case Thermal Resistance					0.32	°C/W
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
$T_{\rm J}$	Operating junction temperature range			-40		150	
$T_{STG}$	Storage Temperature Range		-40		125	°C	
$T_{\rm C}$	Operating Case Temperature			-40		100	
Torque	Mounting torque	To Heatsink	M5	2.5		4.7	N.m
Wt	Package Weight				160	g	

### Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K

$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$
 T: Thermistor temperature at T

### SP4 Package outline (dimensions in mm)



ALL DIMENSIONS MARKED "\*" ARE TOLERANCED AS : + | Ø 1

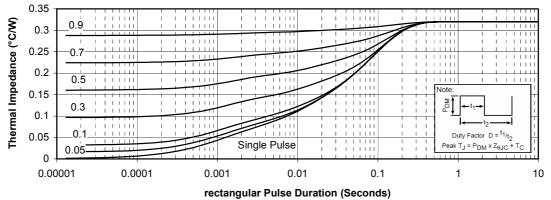
See application note APT0501 - Mounting Instructions for SP4 Power Modules on www.microsemi.com



#### **Typical Performance Curve**

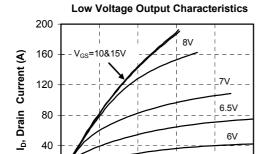
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#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



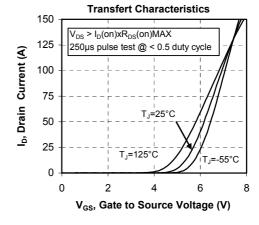
5V

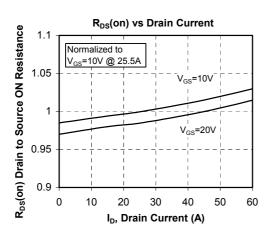
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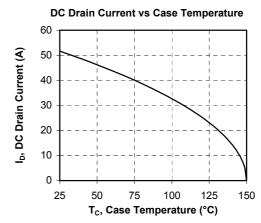


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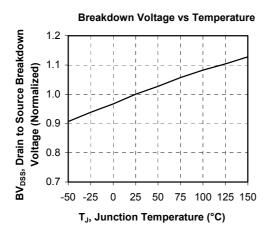
V<sub>DS</sub>, Drain to Source Voltage (V)

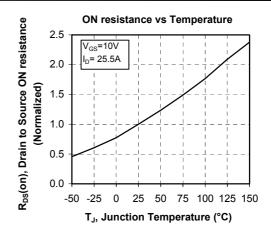


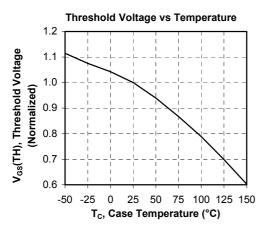


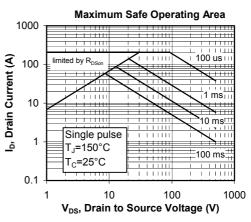


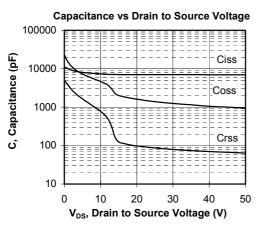


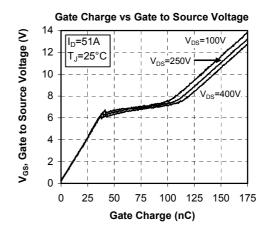




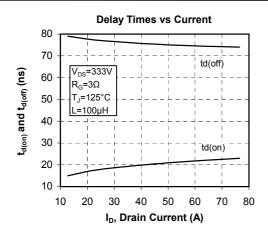


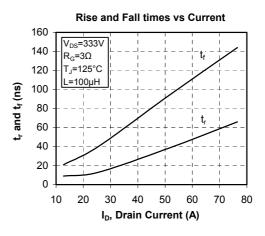


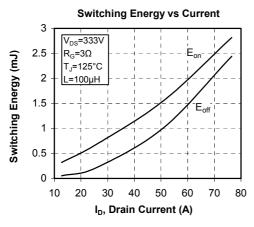


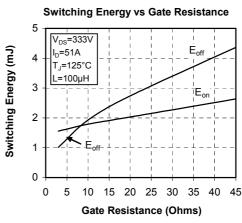


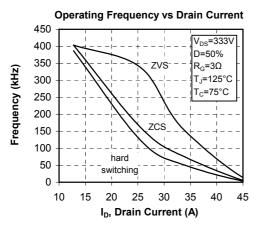


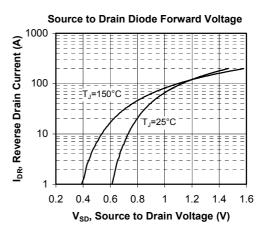














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